- Voltage-Controlled Oscillator (VCO)
  Ring Oscillator Using Only One External Biasing Resistor (R<sub>BIAS</sub>)
- Recommended Lock Frequency
  100 MHz to 130 MHz
  - (V<sub>DD</sub> = 3.3 V + 5%, T<sub>A</sub> = -20°C to 75°C)
- Phase-Frequency Detector (PFD) Includes a High-Speed Edge-Triggered Detector With Internal Charge Pump
- Independent VCO, PFD Power-Down Mode
- Thin Small-Outline Package (14 Terminal)
- Compatible Pin Assignment to TLC2932, TLC2933



## description

The TLC2934, a mixed signal IC designed for phase-locked-loop (PLL) systems, is composed of a voltage-controlled oscillator (VCO) and an edge-triggered-type phase frequency detector (PFD).

The internal VCO is based on the TLC2932 and TLC2933s ring oscillator. It oscillates in wider frequency with lower supply voltage, and it has stable oscillating performance. The oscillation function, provided by only one external resistor connection, supplies bias to the VCI internal circuit. Oscillator range is covered from 10 MHz to 130 MHz with a 3.3-V supply voltage. The VCO has an inhibit function to stop oscillation and for the power-down mode.

The internal PFD, a high-speed rising edge triggered type, has an internal charge pump with a high-impedance output buffer. The PFD detects phase difference between the reference frequency input and the signal frequency input from the VCO output through an external counter device. This functions the same as TLC2932 and TLC2933. The PFD also has the inhibit function for stop phase comparison and for power-down mode.

### block diagram





Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

PRODUCTION DATA information is current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.



Copyright © 2000, Texas Instruments Incorporated

SLAS306 - NOVEMBER 2000

## **Terminal Functions**

TERMINAL			DECODIPTION
NAME	NO.	1/0	DESCRIPTION
FIN-A, FIN-B	4 5	I	Frequency signal inputs for PFD. The reference frequency signal ( $f_{REF-IN}$ ) and the VCO output signal through the external counter device are applied to these terminals. When the LPF design is the lag-lead filter (passive filter and noninverting), $f_{(REF-IN)}$ is input to FIN-A, and the VCO output signal is to FIN-B.
LOGIC GND	7		GND terminal for the internal logic circuit
LOGIC V <sub>DD</sub>	1		Power supply terminal for the internal logic circuit. This power supply terminal separates from VCO $V_{DD}$ to reduce cross-coupling between supplies.
PFD INHIBIT	9	I	PFD INHIBIT (power-down) control signal input terminal
PFD OUT	6	0	PFD output terminal. When PFD INHIBIT is high, PFD OUT is in the high-impedance state.
RBIAS	13	I	Bias resistor (R <sub>BIAS</sub> ) terminal. Connect a resistor between VCO GND and this terminal to supply bias to internal VCO circuit. TLC2934 bias resistor connection is different from TLC2932 and TLC2933, where bias resistor R <sub>BIAS</sub> is connected to VCO V <sub>DD</sub> .
SELECT	2	1	1/2 divider select terminal. L=through output, H=1/2 output.
TEST	8		Test terminal. Use for production test. Tie to GND when in normal use.
VCO GND	11		GND terminal for internal VCO
VCO OUT	3	0	VCO output terminal. When VCO INHIBIT = high, VCO OUT is low.
VCO INHIBIT	10	I	VCO INHIBIT (power-down) control signal input terminal
VCO IN	12	I	VCO control voltage input terminal. Normally, The external LPF is connected to this terminal.
VCO V <sub>DD</sub>	14		Power supply terminal for the internal VCO circuit. This power supply terminal should be separate from LOGIC $V_{DD}$ to reduce cross-coupling between supplies.

### absolute maximum ratings over operating free-air temperature (unless otherwise noted)<sup>†</sup>

Supply voltage (each supply), V <sub>DD</sub> (see Note 1)	–0.5 V to 4 V
Input voltage range (each input), VI (see Note 1)	–0.5 V to V <sub>DD</sub> + 0.5 V
Input current (each input), I	±20 mA
Output current (each output), IO	±20 mA
Continuous total power dissipation at (or below) $T_A = 25^{\circ}C$ (see Note 2), $P_D$	700 mW
Operating free-air temperature range. T <sub>A</sub>	–20°C to 75°C
Storage temperature range, T <sub>stg</sub>	–65°C to 150°C
Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds	260°C

<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. All voltage values are with respect to network ground terminal.

2. For operation above 25°C free-air temperature, derate linearly at the rate of 5.6 mW/°C



SLAS306 - NOVEMBER 2000

## recommended operating conditions

		MIN	TYP	MAX	UNIT
Supply voltage (each supply, V <sub>DD</sub> (s	3.15	3.3	3.45	V	
Input voltage (each input except for	VCO IN, VI	0		V <sub>DD</sub>	V
Output current (each output), IO		0		±2	mA
VCO control voltage, V <sub>CO IN</sub>				V <sub>DD</sub>	V
	$R_{BIAS} = 1 k\Omega$	36		130	MHz
	$R_{BIAS} = 1.8 \text{ k}\Omega$	28		90	
Lock frequency (through output)	$R_{BIAS} = 2.4 k\Omega$	26		80	
	$R_{BIAS} = 3.3 k\Omega$	20		60	
	$R_{BIAS} = 1 k\Omega$	18		65	MHz
Look fraguanov (1/2 output)	$R_{BIAS} = 1.8 \text{ k}\Omega$	14		45	
	$R_{BIAS} = 2.4 k\Omega$	13		40	
	$R_{BIAS} = 3.3 k\Omega$	10		30	
Bias resistor, R <sub>BIAS</sub>				3.3	KΩ
Operating temperature range, T <sub>A</sub>				75	°C
V <sub>CO IN</sub> voltage at VCO INHIBIT $\downarrow$ , V	V <sub>CO IN</sub> voltage at VCO INHIBIT↓, V <sub>(CINH)</sub> (see Note 5)				V

NOTES: 3. It is recommended that the logic supply terminal (LOGIC V<sub>DD</sub>) and the VCO supply terminal (VCO V<sub>DD</sub>) be at the same voltage and separated from each other.

4. A bypass capacitor is placed as close as possible to each supply terminal.

5. For stable restart of VCO, V<sub>COIN</sub> is 0 V when VCO INHIBIT is pulled down to GND level to disable the VCO INHIBIT function. And also, V<sub>CO IN</sub> should be 0 V when the operation will be started by supplying the power.

# electrical characteristics over recommended operating free-air temperature range, V<sub>DD</sub>=3.3 V (unless otherwise noted)

#### VCO

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
VOH	High-level output voltage	$I_{OH} = -2 \text{ mA}$	3.1			V
VOL	Low-level output voltage	I <sub>OL</sub> = 2 mA			0.2	V
VIH	High-level input voltage	Logic signal input	2.3			V
VIL	Low-level input voltage	Logic signal input			1.0	V
lį	Input current at TEST, VCO INHIBIT	$V_I = V_{DD}$ or GND			±1	μA
ZV(CO IN)	Input impedance at V <sub>COIN</sub>	$V_{COIN} = 1/2 V_{DD}$		10		MΩ
IDD(INH)	VCO supply current (inhibit)	See Note 6		0.01	1	μA
IDD(VCO)	VCO supply current	See Note 7		10	15	mA

NOTES: 6. Current into VCO  $V_{DD}$ , when VCO INHIBIT =  $V_{DD}$ , PFD is inhibited.

7. Current into VCO V<sub>DD</sub>, when V<sub>COIN</sub> = 1/2 V<sub>DD</sub>, R<sub>BIAS</sub> = 1 k $\Omega$ , VCO INHIBIT = GND, PFD is inhibited.

SLAS306 - NOVEMBER 2000

# electrical characteristics over recommended operating free-air temperature range, V<sub>DD</sub>=3.3 V (unless otherwise noted) (continued)

#### VCO

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
VOH	High-level output voltage	$I_{OH} = -2 \text{ mA}$	3.1			V
VOL	Low-level output voltage	I <sub>OL</sub> = 2 mA			0.2	V
Ioz	High-impedance state output current	PFD INHIBIT = high, $V_O = V_{DD}$ or GND			±1	μΑ
VIH	High-level input voltage at FIN–A,B		2.3			V
VIL	Low-level input voltage at FIN–A,B				1.0	V
V(TO)	Positive input threshold voltage at PFD INHIBIT		1.0	1.65	2.3	V
Cl	Input capacitance at FIN-A,B			5		pF
Z <sub>(IN)</sub>	Input impedance at FIN-A,B			10		MΩ
IDD(PFD)	PFD supply current	See Note 8		1.5	6.0	mA

NOTE 8: Current into LOGIC V<sub>DD</sub>, when FIN-A, FIN-B=50 MHz ( $V_{I(pp)}$  = 3.3V, rectangular wave), Test=GND, no load, and VCO OUT is inhibited.

#### VCO

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
f(OSC)	Operating oscillation frequency	$R_{BIAS} = 1 k\Omega$	67	90	113	MHz
t(STB)	Time to stable oscillation	See Note 9		0.7	10	μs
tr	Rise time	C <sub>L</sub> = 15 pF, See Figure 3		1.7	5	ns
t <sub>f</sub>	Fall time	C <sub>L</sub> = 15 pF, See Figure 3		1.1	4	ns
f(duty)	Duty cycle at VCO OUT	$R_{BIAS} = 1.0 \text{ k}\Omega, V_{CO IN} = 1/2 \text{ V}_{DD}$	45%	50%	55%	
	Temperature coefficient of oscillation frequency	$R_{BIAS}$ =1.0kΩ, V <sub>CO IN</sub> = 1/2 V <sub>DD</sub> , T <sub>A</sub> = -20°C to 75°C		0.03		%/°C
	Supply voltage coefficient of oscillation frequency			0.02		%/mV
	Jitter absolute	$R_{BIAS} = 1 \text{ k}\Omega, \text{ V}_{CO \text{ IN}} = 1/2 \text{ V}_{DD}$		50		ps

NOTE 9: Current into VCO V\_DD, when VCO INHIBIT = V\_DD, PFD is inhibited.

## PFD AC

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
fMAX	Maximum operating frequency		50			MHz
t <sub>PLZ</sub>	PFD output disable time from low level	See Figures 4 and 5 and Table 6		15.3	40	ns
<sup>t</sup> PHZ	PFD output disable time from high level			15.5	40	ns
tPZL	PFD output enable time from low level			2.4	10	ns
<sup>t</sup> PZH	PFD output enable time from high level			2.5	10	ns
t <sub>r</sub>	Rise time	C <sub>L</sub> =15 pF (see Figure 3)		1.2	5	ns
t <sub>f</sub>	Fall time	C <sub>L</sub> =15 pF (see Figure 3)		0.7	5	ns



90%

SLAS306 - NOVEMBER 2000



## PARAMETER MEASUREMENT INFORMATION

90%

 $^{\dagger}$  FIN-A and FIN-B are for reference phase only, not for timing.



PFD Output Test Conditions							
PARAMETER	RL	CL	SL	S <sub>2</sub>			
<sup>t</sup> PZH							
<sup>t</sup> PHZ			Open	Close			
tr	1.60	45					
<sup>t</sup> PZL	1 K32	тэрг					
<sup>t</sup> PLZ			Close	Open			
tf							



Figure 3. PFD Output Test Condition



SLAS306 - NOVEMBER 2000







SLAS306 - NOVEMBER 2000

# PW (R-PDSO-G\*\*)

#### PLASTIC SMALL-OUTLINE PACKAGE

**14 PINS SHOWN** 



NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion not to exceed 0,15.
- D. Falls within JEDEC MO-153



## PACKAGING INFORMATION

Orderable Device	Status <sup>(1)</sup>	Package Type	Package Drawing	Pins	Package Qty	e Eco Plan <sup>(2)</sup>	Lead/Ball Finish	MSL Peak Temp <sup>(3)</sup>
TLC2934IPW	NRND	TSSOP	PW	14	90	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
TLC2934IPWG4	NRND	TSSOP	PW	14	90	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
TLC2934IPWR	NRND	TSSOP	PW	14	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM

<sup>(1)</sup> The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

**PREVIEW:** Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details. TBD: The Pb-Free/Green conversion plan has not been defined.

**Pb-Free (RoHS):** TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

**Pb-Free (RoHS Exempt):** This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

<sup>(3)</sup> MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

**Important Information and Disclaimer:**The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

#### **IMPORTANT NOTICE**

Texas Instruments Incorporated and its subsidiaries (TI) reserve the right to make corrections, modifications, enhancements, improvements, and other changes to its products and services at any time and to discontinue any product or service without notice. Customers should obtain the latest relevant information before placing orders and should verify that such information is current and complete. All products are sold subject to TI's terms and conditions of sale supplied at the time of order acknowledgment.

TI warrants performance of its hardware products to the specifications applicable at the time of sale in accordance with TI's standard warranty. Testing and other quality control techniques are used to the extent TI deems necessary to support this warranty. Except where mandated by government requirements, testing of all parameters of each product is not necessarily performed.

TI assumes no liability for applications assistance or customer product design. Customers are responsible for their products and applications using TI components. To minimize the risks associated with customer products and applications, customers should provide adequate design and operating safeguards.

TI does not warrant or represent that any license, either express or implied, is granted under any TI patent right, copyright, mask work right, or other TI intellectual property right relating to any combination, machine, or process in which TI products or services are used. Information published by TI regarding third-party products or services does not constitute a license from TI to use such products or services or a warranty or endorsement thereof. Use of such information may require a license from a third party under the patents or other intellectual property of the third party, or a license from TI under the patents or other intellectual property of TI.

Reproduction of information in TI data books or data sheets is permissible only if reproduction is without alteration and is accompanied by all associated warranties, conditions, limitations, and notices. Reproduction of this information with alteration is an unfair and deceptive business practice. TI is not responsible or liable for such altered documentation.

Resale of TI products or services with statements different from or beyond the parameters stated by TI for that product or service voids all express and any implied warranties for the associated TI product or service and is an unfair and deceptive business practice. TI is not responsible or liable for any such statements.

Following are URLs where you can obtain information on other Texas Instruments products and application solutions:

Products		Applications	
Amplifiers	amplifier.ti.com	Audio	www.ti.com/audio
Data Converters	dataconverter.ti.com	Automotive	www.ti.com/automotive
DSP	dsp.ti.com	Broadband	www.ti.com/broadband
Interface	interface.ti.com	Digital Control	www.ti.com/digitalcontrol
Logic	logic.ti.com	Military	www.ti.com/military
Power Mgmt	power.ti.com	Optical Networking	www.ti.com/opticalnetwork
Microcontrollers	microcontroller.ti.com	Security	www.ti.com/security
Low Power Wireless	www.ti.com/lpw	Telephony	www.ti.com/telephony
		Video & Imaging	www.ti.com/video
		Wireless	www.ti.com/wireless

Mailing Address:

Texas Instruments

Post Office Box 655303 Dallas, Texas 75265

Copyright © 2006, Texas Instruments Incorporated